

Notice of References Cited	Application/Control No. 10/777,506		Applicant(s)/Patent Under Reexamination BAUDAT, NED	
	Examiner Richard L. Leung		Art Unit 3744	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2,332,227	10-1943	JACKSON JAMES O	405/131
	B	US-2,964,917	12-1960	JOHN WEBSTER THOMAS	62/50.3
	C	US-3,047,184	07-1962	BERGEN JOHANNES C VAN; et. al.	220/560.12
	D	US-3,076,317	02-1963	LA FAVE IVAN V	405/131
	E	US-3,225,552	12-1965	FARKAS GEORGE B	62/50.2
	F	US-3,274,785	09-1966	LANGE KENNETH W	405/131
	G	US-3,448,886	06-1969	TODD GORDON; et. al.	220/560.12
	H	US-3,791,164	02-1974	Laverman, Royce Jay	62/48.3
	I	US-3,930,590	01-1976	Ebbrell, Harold K.	220/560.03
	J	US-3,986,340	10-1976	Bivins, Jr., Henry W.	62/50.2
	K	US-4,209,267	06-1980	Gnaedinger, John P.	405/53
	L	US-6,199,329 B1	03-2001	Witter, Aldyr	52/167.7
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 51120422 A	10-1976	Japan	TSUNODA et al.	F17C 03/04
	O	JP 53132810 A	11-1978	Japan	YOKOYAMA et al.	F17C 13/08
	P	JP 09177359 A	07-1997	Japan	MIYAGAWA, HITOSHI	E04H 07/02
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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